

Notice of References Cited	Application/Control No. 10/730,568	Applicant(s)/Patent Under Reexamination SHIN ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,771,909 B2	08-2004	Farhan et al.	398/72
*	B	US-6,018,540 A	01-2000	Kinoshita, Junichi	372/46.01
*	C	US-5,398,008 A	03-1995	Nissler et al.	332/178
*	D	US-6,873,632 B2	03-2005	Hsieh, John	372/38.02
*	E	US-6,859,477 B2	02-2005	Deppe et al.	372/45.01
*	F	US-2005/0018732 A1	01-2005	Bond et al.	372/050
*	G	US-2005/0123298 A1	06-2005	Kim et al.	398/070
*	H	US-2005/0281298 A1	12-2005	Kupershmidt et al.	372/034
*	I	US-5,398,256 A	03-1995	Hohimer et al.	372/94
*	J	US-5,651,016 A	07-1997	Yu et al.	372/34
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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